

**Notice of References Cited**

Application/Control No.

10/057,603

Applicant(s)/Patent Under  
Reexamination  
ITO, HIDEKI

Examiner

TAN X. DINH

Art Unit

2653

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,442,108 B1	08-2002	Kurihara et al.	369/30.05
	B	US-6,487,145 B1	11-2002	Berhan, Michel D.	369/30.15
	C	US-6,680,879 B2	01-2004	Kato et al.	369/30.05
	D	US-6,587,404 B1	07-2003	Keller et al.	369/30.06
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2002-170,325 A	06-2002	JAPAN	ITO, HIDEKI	369/30.09
	O	2001-266,554 A	09-2001	JAPAN	YAMAGUCHI	369/30.09
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.